

November 2013

## FQPF5N40

# N-Channel QFET® MOSFET

**400 V, 3.0 A, 1.6** Ω

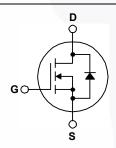
### **Description**

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 3.0 A, 400 V,  $R_{DS(on)}$  = 1.6  $\Omega$  (Max.) @  $V_{GS}$  = 10 V,  $I_D$  = 1.5 A
- Low Gate Charge (Typ. 10 nC)
- · Low Crss (Typ. 7 pF)
- · 100% Avalanche Tested





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter	FQPF5N40	Unit
$V_{DSS}$	Drain-Source Voltage	400	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)	3.0	Α
	- Continuous (T <sub>C</sub> = 100°C)	1.9	Α
I <sub>DM</sub>	Drain Current - Pulsed (Note 1)	12	Α
V <sub>GSS</sub>	Gate-Source Voltage	± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	290	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	3.0	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	3.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
$P_{D}$	Power Dissipation (T <sub>C</sub> = 25°C)	35	W
	- Derate Above 25°C	0.28	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds	300	°C

## **Thermal Characteristics**

Symbol	Parameter FQPF5N		Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	3.57	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max. 62.5		C/VV

# Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQPF5N40	FQPF5N40	TO-220F	Tube	N/A	N/A	50 units

## **Electrical Characteristics**

T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Uni
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA				V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.38		V/°(
I <sub>DSS</sub>	Zana Oata Valtana Brain Ourrant	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V			1	μΑ
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 320 V, T <sub>C</sub> = 125°C			10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nΑ
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse				-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A	-	1.27	1.6	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.5 A		2.8		S
C <sub>iss</sub>	Input Capacitance Output Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		350 60	460 80	pF pF
	ic Characteristics Input Capacitance	Vpc = 25 V Vcc = 0 V		350	460	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			7	9	pF
	ing Characteristics	)		40	20	
d(on)	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 200 \text{ V}, I_D = 4.5 \text{ A},$		12	30	ns
t <sub>r</sub>	Turn-Off Delay Time	$R_G = 25 \Omega$		60 20	130 50	ns
t <sub>d(off)</sub>	Turn-Off Fall Time	(Note 4)				ns
t <sub>f</sub> Q <sub>g</sub>				30 10	70 13	ns
	Total Gate Charge	$V_{DS} = 320 \text{ V}, I_D = 4.5 \text{ A},$				
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V (Note 4)	-	3.0 4.5		nC nC
Q <sub>gd</sub>	Gate-Drain Charge	(NOIE 4)		4.0		ПС
	Sauras Diada Charastaristica e	nd Maximum Patings				
Drain-S	Source Diode Characteristics a	iu maxiiiuiii Natiiigs				
Drain-S	Maximum Continuous Drain-Source Did				3.0	Α

## Q<sub>rr</sub> Notes

 $V_{SD}$ 

 $t_{rr}$ 

Drain-Source Diode Forward Voltage

Reverse Recovery Time

Reverse Recovery Charge

1.5

190

1.0

V

ns

μC

 $V_{GS} = 0 \text{ V}, I_{S} = 3.0 \text{ A}$ 

 $V_{GS} = 0 \text{ V}, I_{S} = 4.5 \text{ A},$ 

 $dI_F / dt = 100 A/\mu s$ 

 $<sup>{\</sup>bf 1.}\ Repetitive\ rating: pulse-width\ limited\ by\ maximum\ junction\ temperature.$ 

<sup>2.</sup> L = 56 mH, I<sub>AS</sub> = 3.0 A, V<sub>DD</sub> = 50 V, R<sub>G</sub> = 25  $\Omega$ , starting T<sub>J</sub> = 25°C.

<sup>3.</sup>  $I_{SD} \leq$  4.5 A, di/dt  $\leq$  200 A/ $\mu$ s,  $V_{DD} \leq$  BV $_{DSS}$ , starting  $T_J$  = 25°C.

<sup>4.</sup> Essentially independent of operating temperature.

## **Typical Characteristics**

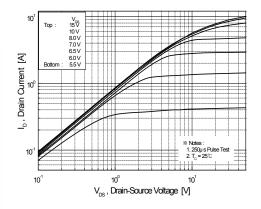


Figure 1. On-Region Characteristics

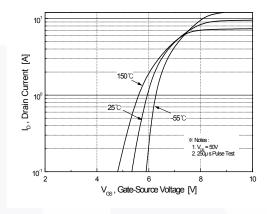


Figure 2. Transfer Characteristics

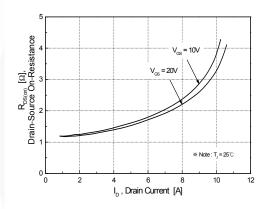


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

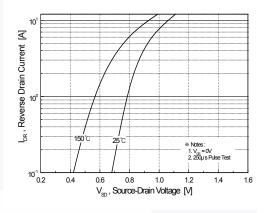


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

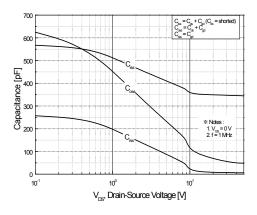


Figure 5. Capacitance Characteristics

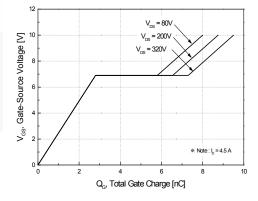


Figure 6. Gate Charge Characteristics

## Typical Characteristics (continued)

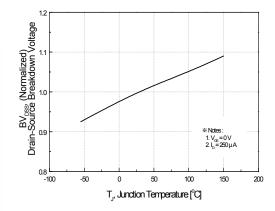
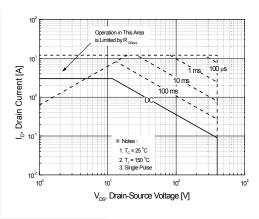


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



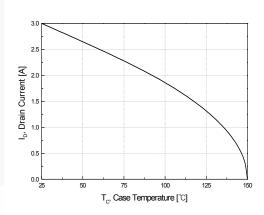


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

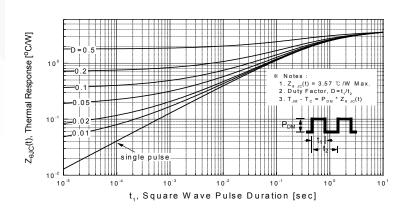


Figure 11. Transient Thermal Response Curve

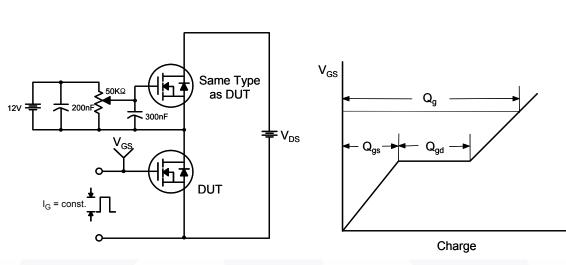


Figure 12. Gate Charge Test Circuit & Waveform

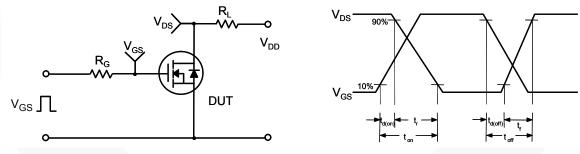


Figure 13. Resistive Switching Test Circuit & Waveforms

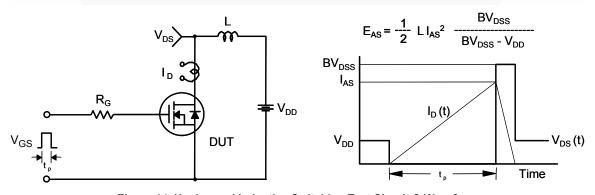
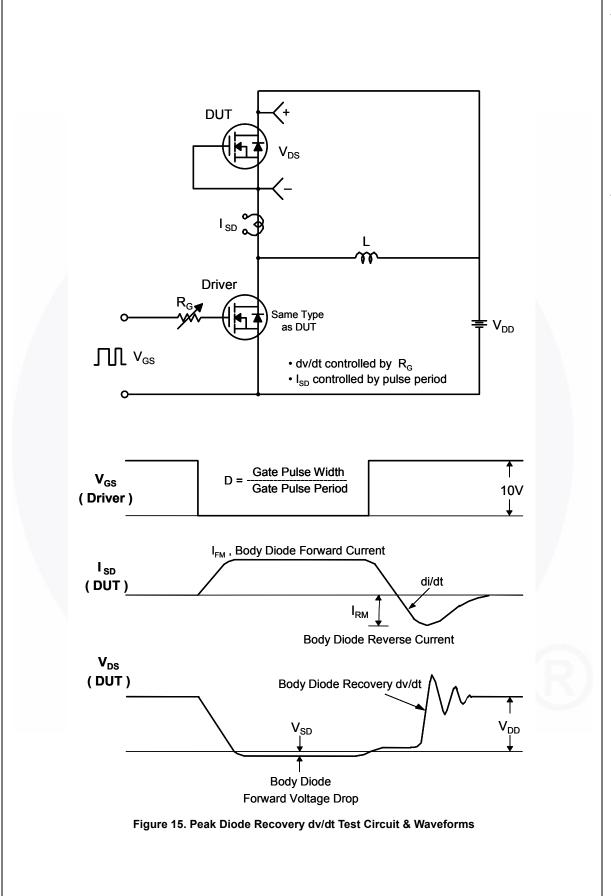


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



## **Mechanical Dimensions**

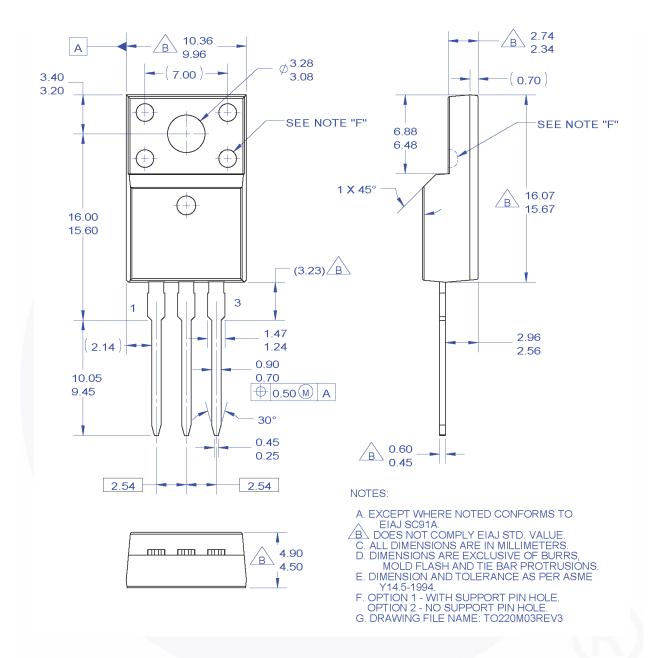


Figure 16. TO220, Molded, 3-Lead, Full Pack, EIAJ SC91, Straight Lead

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